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	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/898,136	CHEN ET AL.	
l	Examiner	Art Unit	
	Minh Dinh	2132	

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Class	Subclass	Date	Examiner
380	210-211	5/20/2005	MD
	231-232	1	1
	239-240		
725	29		
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